	<u>ESC</u>	C	I	DC	CUMENT	CHANGE REQUEST				
DCR number	706	Changes re	quired for: C	Gene	eral	Originator: Steve Thacker				
Date: 2015/04/17 Date sent: 2012/02/06			2012/02/06	;		Organisation: ESCC Executive Secretariat				
Status: IMPLE	MENTED					Secretariat				
Title:	Generic Specification for Capacitors Fixed Chips Ceramic Dielectric Types I and II									
Number:	3009 Issue:		lssue:	1						
Other documents affected:										
Page:										
ESCC 3009 issue 1, page 23 ESCC 3009 issue 1, page 24										
ESCC3009 issue 2 Draft B, page16 ESCC3009 issue 2 Draft B, page16										
Paragraph:										
ESCC 3009 issue 1, Para 9.4.1.3 ESCC 3009 issue 1, Para 9.4.1.4.1										
ESCC3009 issue 2 Draft B, Para 8.4.1.3 ESCC3009 issue 2 Draft B, Para 8.4.1.4										
Original wording:										
See below & original spec										
Proposed wording:										
Generic spec is proposed to be amended as follows: Note - Either the currently published Generic spec issue 1, or converted Generic Draft 2B currently being reviewed by ESA per DCR rasied 22/11/2011.										
 A) Insulation Resistance Measurement: Amend the duration of the applied voltage to be as follows: the duration of the applied voltage shall be sufficient to verify the specified insulation resistance limit is met, up to 1 minute maximum. 										
Note: currently the specified duration is 60 +/- 5 seconds										

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 B) Voltage Proof Measurement: Amend the duration of the applied voltage to be as follows: the duration of the applied voltage shall be sufficient to verify no component breakdown or flashover, up to 1 minute maximum. Note: currently the specified duration is 1 minute. 									
Justification:									
The duration of the test should be sufficient to verify the test has been performed correctly and that the components meets the specified limits. Forcing a fixed duration of 1 minute is not warranted for these 2 tests, especially as burn-in for 168hours is performed at the same test voltage. Minimising the duration of the test minimises the associated cost of performing the test on the full lot of components.									
Attachments:									
N/A									
Modifications:									
As per PSWG No 59 (27/6/2013) Unanimously approved with disposition named solution 2 as per Astrium/Alain Mouton email dated 13-6-2013. Here below the solution 2 text which is a sentence derived from the TM 302 of MIL-STD-202: disposition.									
The voltage shall be applied continuously during one minute (max) before the reading of the resistance. If the specified limit is met, and steady or increasing, then the test may be stopped before the end of the Minute									
Approval signature:									
la s									
Date signed:									
2015-04-17									